

Notice of References Cited	Application/Control No. 10/661,934		Applicant(s)/Patent Under Reexamination ESPENSCHIED, MARK DORTON	
	Examiner Sue A. Weaver		Art Unit 3727	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,415,937	07-2002	DeJong et al.	215/386
*	B	US-4,703,863	11-1987	Kohus, Louis M.	215/11.1
*	C	US-5,024,341	06-1991	Dekerle, Benoit	215/11.1
*	D	US-2003/0192851	10-2003	Ziegler, Scott W.	215/11.5
*	E	US-D486,225	02-2004	Gay, III, Randolph G.	D24/109
*	F	US-6,354,449	03-2002	Smith, Louis F.	215/11.1
*	G	US-6,499,615	12-2002	Szieff et al.	215/11.5
*	H	US-D414,873	10-1999	Kwecinski, David B.	D24/197
*	I	US-6,851,565	02-2005	Stephan, Gerard	215/389
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 200170406 A	03-2001	Japan	FUKUNAGA	
	O	JP 200285527 A	03-2002	Japan	OSUMI	
	P	FR 2653012 A1	04-1991	France	JACQUES, PARTOUCHE	
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.